

[LTC](https://www.analog.com/LTC6373?doc=LTC6373.pdf)6373

36V Fully-Differential Programmable-Gain Instrumentation Amplifier with 25pA Input Bias Current

- Pin-Programmable Gains:  $G = 0.25, 0.5, 1, 2, 4, 8, 16$ V/V + Shutdown
- Fully Differential Outputs
- Gain Error:  $0.012%$  (Max)
- Gain Error Drift: 1ppm/°C (Max)
- $\blacksquare$  CMRR: 103dB (Min), G = 16
- Input Bias Current: 25pA (Max)
- n Input Offset Voltage:  $92\mu$ V (Max),  $G = 16$
- n Input Offset Voltage Drift: 1.7μV/°C (Max),  $G = 16$
- $\blacksquare$  -3dB Bandwidth: 4MHz, G = 16
- n Input Noise Density: 8nV/ $\sqrt{Hz}$ , G = 16
- Slew Rate:  $12V/\mu s$ ,  $G = 16$
- Adjustable Output Common Mode Voltage
- Quiescent Supply Current: 4.4mA
- Supply Voltage Range:  $±4.5V$  to  $±18V$
- $-40^{\circ}$ C to 125°C Specified Temperature Range
- Small 12-Lead 4mm  $\times$  4mm DFN (LFCSP) Package

### **APPLICATIONS**

- Data Acquisition Systems
- $\blacksquare$  Biomedical Instrumentation
- Test and Measurement Equipment
- Differential ADC Drivers
- Single-Ended-to-Differential Conversion
- Multiplexed Applications

# TYPICAL APPLICATION



# FEATURES DESCRIPTION

The [LTC®6373](https://www.analog.com/LTC6373?doc=LTC6373.pdf) is a precision instrumentation amplifier with fully differential outputs which includes a closelymatched internal resistor network to achieve excellent CMRR, offset voltage, gain error, gain drift, and gain nonlinearity. The user can easily program the gain to one of seven available settings through a 3-bit parallel interface (A2 to A0). The 8th state puts the part in shutdown which reduces the current consumption to 220μA. Unlike a conventional voltage feedback amplifier, the LTC6373 maintains nearly the same bandwidth across all its gain settings.

The LTC6373 features fully differential outputs to drive high performance, differential-input ADCs. The output common mode voltage is independently adjustable via the  $V_{\Omega CM}$  pin. The combination of high impedance inputs, DC precision, low noise, low distortion, and high-speed differential ADC drive makes the LTC6373 an ideal candidate for optimizing data acquisition systems.

The LTC6373 is available in a 12-lead  $4 \text{mm} \times 4 \text{mm}$  DFN (LFCSP) package and is fully specified over the −40°C to 125°C temperature range.

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# ABSOLUTE MAXIMUM RATINGS PIN CONFIGURATION

**(Note 1)**

#### Supply Voltages





### ORDER INFORMATION



Contact the factory for parts specified with wider operating temperature ranges. \*The temperature grade is identified by a label on the shipping container. [Tape and reel specifications.](https://www.analog.com/media/en/package-pcb-resources/package/tape-reel-rev-n.pdf?doc=LTC6373.pdf) Some packages are available in 500 unit reels through designated sales channels with #TRMPBF suffix.

#### <span id="page-2-0"></span>**ELECTRICAL CHARACTERISTICS** The  $\bullet$  denotes the specifications which apply over the full operating

temperature range, otherwise specifications and all typical values are at T<sub>A</sub> = 25°C. V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>+</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = DGND = OV, G = 1 (A2 = 5V, A1 = A0 = 0V). V<sub>S</sub> is defined as (V<sup>+</sup> – V<sup>-</sup>). V<sub>ICM</sub> is defined as (V<sub>+IN</sub> + V<sub>–IN</sub>)/2. V<sub>OUTCM</sub> is defined as (V<sub>+OUT</sub> + V<sub>–OUT</sub>)/2. **VOUTDIFF is defined as (V+OUT – V–OUT).** 



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# ELECTRICAL CHARACTERISTICS

**Note 1:** Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

**Note 2:** The LTC6373 is capable of producing peak output currents in excess of 40mA. Current density limitations within the IC require the continuous RMS current supplied by the output (sourcing or sinking) over the operating lifetime of the part be limited to under 40mA (Absolute Maximum).

**Note 3:** A heat sink may be required to keep the junction temperature below absolute maximum when the output is shorted indefinitely.

**Note 4:** The LTC6373I is guaranteed functional over the operating temperature range of –40°C to 85°C. The LTC6373H is guaranteed functional over the operating temperature range of –40°C to 125°C.

**Note 5:** The LTC6373I is guaranteed to meet specified performance from –40°C to 85°C. The LTC6373H is guaranteed to meet specified performance from –40°C to 125°C.

**Note 6:** Guaranteed by design.

**Note 7:** ESD (Electrostatic Discharge) sensitive device. ESD protection devices are used extensively internal to the LTC6373; however, high electrostatic discharge can damage or degrade the device. Use proper ESD handling precautions.

**Note 8:** Input bias current is defined as the maximum of the input currents flowing into either of the input pins (–IN and +IN). Input Offset current is defined as the difference between the input currents ( $I_{OS} = I_B^+ - I_B^-$ ).

**Note 9:** Input CMRR (CMRR) is defined as the ratio of the change in the input common mode voltage at the pins +IN or –IN to the change in differential input referred offset voltage. Output CMRR (CMRRIO) is defined as the ratio of the change in the voltage at the  $V_{\Omega CM}$  pin to the change in differential input referred offset voltage.

**Note 10:** Differential power supply rejection ratio (PSRR) is defined as the ratio of the change in supply voltage to the change in differential input referred offset voltage. Common mode power supply rejection ratio (PSRRCM) is defined as the ratio of the change in supply voltage to the change in the common mode offset voltage.

**Note 11:** This parameter is measured in a high speed automatic tester that does not measure the thermal effects with longer time constants. The magnitude of these thermal effects are dependent on the package used, PCB layout, heat sinking and air flow conditions.

**Note 12:** Hysteresis in output voltage is created by mechanical stress that differs depending on whether the IC was previously at a higher or lower temperature. Output voltage is always measured at 25°C, but the IC is cycled to the hot or cold temperature limit before successive measurements. For instruments that are stored in well controlled temperatures (within 20 or 30 degrees of operational temperature), hysteresis is usually not a significant error source. Typical Hysteresis is the worst case of differential offset measured between 25°C to -40°C to 25°C thermal cycle and 25°C to 125°C to 25°C thermal cycle.

V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.

#### **Typical Distribution of Differential Typical Distribution of Differential RTI Offset Voltage RTI Offset Voltage** 35  $G = 16$  $T_A = 25^{\circ}C$ 30  $-1500$  UNITS PERCENTAGE OF UNITS (%) PERCENTAGE OF UNITS (%) 25 20 15 10 5 0 –100 –80 –60 –40 –20 0 20 40 60 80 100 DIFFERENTIAL RTI OFFSET VOLTAGE (µV) 6373 G01

**Typical Distribution of Differential Typical Distribution of Differential RTI Offset Voltage Drift RTI Offset Voltage Drift**







#### DIFFERENTIAL RTI OFFSET VOLTAGE (µV) 6373 G02

**Typical Distribution of Differential Typical Distribution of Differential RTI Offset Voltage Drift RTI Offset Voltage Drift**



#### **Typical Distribution of Differential Typical Distribution of Differential RTI Offset Voltage RTI Offset Voltage**



#### **Typical Distribution of Differential Typical Distribution of Differential RTI Offset Voltage Drift RTI Offset Voltage Drift**









**Typical Distribution of CMRR**



Rev. 0

V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.











**Typical Distribution of Differential Typical Distribution of Differential Gain Nonlinearity Gain Nonlinearity**



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Rev. 0

#### TYPICAL PERFORMANCE CHARACTERISTICS

V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.



FREQUENCY (Hz)

 $- - - G = 2$  $\cdots$  G = 1

 $G = 16$ G = 8 G = 4

6373 G24

 $G = 0.5$  $\rightarrow - G = 0.25$ 

FREQUENCY (Hz) 0.1 1 10 100 1k 10k 100k 1M

6373 G23

V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.



**Input Referred Voltage Noise Density vs Frequency Density vs Frequency**



**Input Referred 0.1Hz to 10Hz Voltage Noise (G = 4)**





**Input Referred 0.1Hz to 10Hz Voltage Noise (G = 16)**



**Long Term Differential RTI Offset Long Term Differential RTI Voltage Drift Voltage**  3 2.5 DIFFERENTIAL RTI OFFSET VOLTAGE (IV) DIFFERENTIAL RTI OFFSET VOLTAGE (µV) 2 1.5 1 CHANGE IN 0.5 0 –0.5 –1 –1.5 –2  $G = 16$ –2.5 6 UNITS, SOLDERED TO PCB –3 0 250 500 750 1000 1250 1500 1750 2000 TIME (HOURS) 6373 G27

**Input Referred 0.1Hz to 10Hz Voltage Noise (G = 8)**



**Input Referred 0.1Hz to 10Hz Voltage Noise (G = 1)**



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**Input Referred 0.1Hz to 10Hz Voltage Noise (G = 2)**



Rev. 0

V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.







**A0 Digital Input Pin Current vs A0 Digital Input Pin Voltage**



**A1 Digital Input Pin Voltage**  $DGND = A2 = A0 = 0V$  $-40^{\circ}$ C 25°C 85°C 125°C A1 VOLTAGE (V) 0 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 0 10 20 30 40 50 60 A1 PIN CURRENT (µA)

**A1 Digital Input Pin Current vs** 

**A2 Digital Input Pin Current vs A2 Digital Input Pin Voltage**



**Supply Current vs Temperature**  $V_S = 9V$  $V_S = 30V$ TEMPERATURE (°C) –50 –25 0 25 50 75 100 125  $4.0$  –  $-50$ 4.1 4.2 4.3 4.4 4.5 4.6 4.7 4.8 4.9 5.0 TOTAL SUPPLY CURRENT (mA) 6373 G40

**Supply Current vs Supply Voltage**

6373 G38



**Shutdown Supply Current vs Temperature**



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V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.





#### **Input Bias Current and Offset Current vs Temperature**



**Input Bias Current and Offset Current vs Temperature**



**Differential RTI Offset Voltage vs Input Common Mode Voltage Large Signal Step Response vs Input Common Mode Voltage**



**Input Bias Current and Offset Current vs Input Common Mode Voltage**



#### **Input Bias Current vs Input Differential Voltage**





**Large Signal Step Response**



V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.







#### **Small Signal Step Response**



#### **Output Voltage Swing vs Load Current**



#### **Small Signal Step Overshoot vs Load Capacitance vs Load Capacitance**



#### **Output Voltage Swing vs Load Resistance**



#### **Settling Time to 8V<sub>P-P</sub> Output Step Step**



#### **High Output Voltage Swing vs Supply Voltage**



V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = -15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.







**2nd Harmonic Distortion vs Frequency**



 $6 - 8$  $--$  G = 4

**Total Harmonic Distortion + Noise vs Frequency**



**3rd Harmonic Distortion vs Frequency**



**Total Harmonic Distortion + Noise vs Frequency**



**Total Harmonic Distortion + Noise Total Harmonic Distortion + Noise vs Output Amplitude vs Output Amplitude**



Rev. 0

V<sup>+</sup> = V<sup>+</sup><sub>OUT</sub> = 15V, V<sup>-</sup> = –15V, V<sub>ICM</sub> = V<sub>OCM</sub> = 0V, T<sub>A</sub> = 25°C, G = 1, unless otherwise noted.



**Output Overdrive Recovery**



**Common Mode Offset Voltage vs Temperature vs Temperature**



### PIN FUNCTIONS

**–IN (Pin 1):** Inverting Input of Instrumentation Amplifier. Input voltage range is between  $V^-$  + 3V and  $V^+$  – 3V.

**A0 (Pin 2):** Digital Gain Programming Pin 0. In combination with A2 and A1, the user can choose the desired gain setting for the LTC6373 (refer to [Gain Selection](#page-17-0) section of this data sheet). The logic threshold for the A0 pin is specified with respect to the voltage on the DGND pin (logic low = any voltage between DGND and DGND  $+$  0.6V; logic high = any voltage between  $DGND + 1.5V$  and  $V^+$ ). If the A0 pin is left floating, an internal resistor pulls its voltage close to the DGND pin, resulting in a default logic low state for this programming pin.

**A1 (Pin 3):** Digital Gain Programming Pin 1. In combination with A2 and A0, the user can choose the desired gain setting for the LTC6373 (refer to [Gain Selection](#page-17-0) section of this data sheet). The logic threshold for the A1 pin is specified with respect to the voltage on the DGND pin (logic low = any voltage between DGND and  $DGND + 0.6V$ ; logic high = any voltage between  $DGND + 1.5V$  and  $V^+$ ). If the A1 pin is left floating, an internal resistor pulls its voltage close to the DGND pin, resulting in a default logic low state for this programming pin.

**V+ (Pin 4):** Positive Power Supply. The operating voltage range for  $V^+$  is  $(V^- + 9V) \le V^+ \le (V^- + 36V)$ .

**V+ OUT (Pin 5):** Positive Power Supply for the Output Differential Amplifier inside the LTC6373 (the amplifier marked as A3 in [Figure 1](#page-16-0) of this data sheet). V $_{\rm{OUT}}$  pin is normally tied to V+ pin, however the user may also choose a lower voltage for V $_{\rm{OUT}}$  to save power dissipation or to help protect ADC inputs. The voltage on V<sup>+</sup><sub>OUT</sub> pin should never be higher than  $V^+$  pin. The operating voltage range for  $V^+$ <sub>OUT</sub> is  $(V^- + 9V) \le V^+$ <sub>OUT</sub>  $\le V^+$ .

**+OUT (Pin 6):** Positive Output Pin of Instrumentation Amplifier.

**–OUT (Pin 7):** Negative Output Pin of Instrumentation Amplifier.

**V<sub>OCM</sub>** (Pin 8): Output Common Mode Reference Voltage. Voltage applied to this pin sets the output common mode voltage level. If the  $V_{\Omega CM}$  pin is left floating, an internal resistor divider creates a default voltage approximately halfway between V $^+$ <sub>OUT</sub> and V $^-$ . The V<sub>OCM</sub> pin should be decoupled to ground with a minimum of 0.1μF bypass capacitor.

**CAP (Pin 9):** Bypass Capacitor Pin. The CAP pin should be decoupled to ground with a 180pF bypass capacitor.

**DGND (Pin 10):** Reference for Digital Gain Programming Pins (A2/A1/A0). DGND is normally tied to ground, however any voltage between  $V^-$  and  $V^+$  – 2.5V may also be chosen. If the DGND pin is left floating, an internal resistor divider creates a default voltage approximately halfway between V<sup>+</sup> and V<sup>-</sup>. The logic threshold for A2/A1/A0 pins is specified with respect to the DGND pin.

**A2 (Pin 11):** Digital Gain Programming Pin 2. In combination with A1 and A0, the user can choose the desired gain setting for the LTC6373 (refer to [Gain Selection](#page-17-0) section of this data sheet). The logic threshold for the A2 pin is specified with respect to the voltage on the DGND pin (logic low = any voltage between DGND and  $DGND + 0.6V$ ; logic high = any voltage between  $DGND + 1.5V$  and  $V^+$ ). If the A2 pin is left floating, an internal resistor pulls its voltage close to the DGND pin, resulting in a default logic low state for this programming pin.

**+IN (Pin 12):** Noninverting Input of Instrumentation Amplifier. Input voltage range is between  $V^-$  + 3V and  $V^+ - 3V$ .

**V– (Exposed Pad Pin 13):** Negative Power Supply. The exposed pad must be soldered to PCB and connected to V–.

### SIMPLIFIED BLOCK DIAGRAM



<span id="page-16-0"></span>

#### **Functional Description**

The LTC6373 is a monolithic instrumentation amplifier based on the classic 3-op-amp topology, as shown in the Block Diagram of [Figure 1](#page-16-0). A parallel interface allows users to digitally program gains to one of the seven available settings  $(G = 0.25, 0.5, 1, 2, 4, 8,$  and  $16$ V/V) while the 8th state puts the part in shutdown mode (which reduces the current drawn from the supplies to 220µA). Gain control is achieved by switching resistors in an internal, precision resistor array (as shown in [Figure 1](#page-16-0)). Although the LTC6373 has a voltage feedback topology, the gain-bandwidth product increases at higher gain settings because each gain has its own frequency compensation, resulting in increased bandwidth at higher gains and minimum phase variation across all gains.

The LTC6373 is optimized to convert a fully differential or single-ended input signal to a low impedance, balanced differential output suitable for driving high performance, analog-to-digital converters (ADCs). The balanced differential nature of the amplifier provides even-order harmonic distortion cancellation, and low susceptibility to common mode noise (like power supply noise). Load capacitances above 50pF to ground or 25pF differentially should be decoupled with 10 $\Omega$  to 50 $\Omega$  of series resistance from each output to prevent oscillation or ringing.

Overall, the LTC6373 simplifies signal chain design by offering:

- High impedance buffering (due to using CMOS technology and the resulting pA input bias current)
- Signal amplification (G>1) and attenuation (G<1) together in one socket at nearly the same bandwidth
- Digital gain programming (which enables changing gain settings easily and rapidly)
- Superior matching specs (due to trimmed, precision internal resistors)
- The ability to drive ADCs directly (due to attributes such as fully differential outputs, good DC precision, low noise, low distortion, and high bandwidth)
- Level shifting (achieved by using  $V_{OCM}$  pin to independently adjust the output common mode voltage to match it to the desired input level of the next stage of the signal chain).

The LTC6373 accommodates all the above features in a small 12-lead 4mm × 4mm DFN (LFCSP) package, making it an excellent solution for applications where size and packing density are important considerations.

#### <span id="page-17-0"></span>**Gain Selection**

The gain of the LTC6373 can be programmed to its desired setting using a digital interface consisting of a digital reference pin DGND and three parallel gain programming pins A2, A1, and A0. The logic threshold for A2/A1/A0 pins is specified with respect to the voltage on the DGND pin. Any voltage between DGND and DGND + 0.6V on A2 or A1 or A0 pins will generate a logic low (L) state for that pin; any voltage between DGND + 1.5V and V+ on A2 or A1 or A0 pins will generate a logic high (H) state for that pin. The gain for the LTC6373 is programmed according to the truth table below:





The permissible voltage range for DGND is between  $V^-$  and  $V^+ - 2.5V$ . However, typically DGND is tied to ground (0V) and A2/A1/A0 pins can be connected to 0V or 5V to generate logic low (L) and logic high (H) states, respectively.

If the DGND pin is left floating, an internal resistor divider creates a default voltage approximately halfway between V+ and V–. Additionally, if A2 or A1 or A0 pins are left floating, internal resistors pull the voltage on each of these pins close to the DGND pin, resulting in a default logic low (L) state for that programming pin. As a result, if A2 and A1 and A0 pins are left floating all at the same time, the LTC6373 will have a gain setting of  $G = 16$ . When these pins are left open, care should be taken to control leakage currents at these pins to prevent inadvertently putting the LTC6373 into an undesired gain setting.

Keep in mind that any change in voltages applied to A2 or A1 or A0 pins from logic low to logic high (or vice versa) immediately results in a gain setting change for LTC6373 (transparent mode).

#### **Valid Input and Output Range**

Instrumentation amplifiers traditionally specify a valid input common mode range and an output swing range. This however often fails to identify swing limitations associated with internal nodes, as they experience a combination of gained differential signal and common mode signal. Referring to the Simplified Block Diagram of [Figure 1](#page-16-0), the output swing of amplifiers A1, A2, and A3 as well as the common mode input range of the output differential amplifier A3 impose limitations on the valid operating range. The graphs in [Figure 2](#page-18-0) show the maximum input common mode voltage limits where a valid output is produced for each gain setting of LTC6373.



<span id="page-18-0"></span>**Figure 2. Input Common Mode Range vs Differential Output Voltage for Each Gain Setting of LTC6373 with No Load**

#### **Diamond Plot Interpretation**

Diamond plots can be used to determine the valid input common mode voltage ( $V<sub>ICM</sub>$ ) operating range for instrumentation amplifiers such as LTC6373. The valid region of operation is where all signals, input or output, are not clipped.

Subplots (a)-(g) of [Figure 2](#page-18-0) show the input common mode voltage ( $V_{ICM}$ ) range allowed for a given differential output voltage ( $V_{\text{OUTDIFF}}$ ), under various combinations of gain (G) and supply ( $V_S$ ) settings. In each plot, the output stage positive supply pin V $^{\mathrm{+}}$ <sub>OUT</sub> is tied to the main positive supply pin V<sup>+</sup>, V<sub>OCM</sub> = 0V (mid-rail) and there is no load.

To identify the valid  $V_{ICM}$  range for a specific application: First, identify the gain and supply conditions that the LTC6373 will be operated under. Then, identify the range of valid differential output voltages ( $V_{\text{OUTDIFF}}$ ) desired. For example, this could be the full-scale signal that is optimal for the subsequent ADC's SNR.

This combination of settings and output range implies a specific differential input signal  $(V_{\text{INDIF}})$  range, since  $V_{INDIFF} = V_{OLITDIFF}/G$ .

While the input signal's  $V_{\text{INDIFF}}$  is fixed when specific  $V_{\text{OUTDIFF}}$  and G are chosen, the input signal's common mode voltage  $V_{ICM}$  is not, because the same  $V_{INDIF}$  can be superimposed on many different  $V_{ICM}$  values.

The valid  $V_{ICM}$  range can be set by the swing limits on +IN and/or –IN, since  $V_{ICM}$  is the average of +IN and –IN. It can also be set by internal node swing limits, since the internal nodes are also operating with common mode voltage  $V_{ICM}$ , and these nodes must also be able to swing enough away from  $V_{ICM}$  to produce the gained-up output.

On a diamond plot, this valid region of operation for  $V_{ICM}$ for a specific output  $V_{\text{OUTDIFF}}$  is indicated by the portion of the vertical line going straight up from  $V_{\text{OUTDIF}}$  that falls inside the diamond borders, as shown in [Figure 3](#page-19-0).

If the part's input common mode voltage is within the  $V<sub>ICM</sub>$  borders of the diamond, there should be no problems with clipping. If the differential input signal is shifted



<span id="page-19-0"></span>**Figure 3. The Blue Arrow Indicates the Range of Valid V<sub>ICM</sub>** Values for V<sub>OUTDIFF</sub> = -12V, Where No Signals are Clipped, **for the**  $V_S = \pm 15V$ **, G = 16 Case** 

by a  $V_{ICM}$  value that is outside of the diamond, either +IN or –IN (or internal nodes) will be clipped, or the output itself will hit the rails, and thus result in a clipped output.

The following example shows how a diamond plot point is determined. For the specific case of  $V_{\text{OUTDIFF}} = -12V$ as shown in [Figure 3,](#page-19-0) the upper limit of  $V_{ICM}$  is 8V, and the lower limit is –8V.

For  $V_{ICM}$  = 8V, if the gained-up input (aka output) is  $-12V$ , the maximum negative internal node swing is 6V above V<sub>ICM</sub>. Referenced to ground, this internal node reaches  $8V + 6V = 14V$ , which is roughly the output high limit of LTC6373 with  $\pm$ 15V supplies. If V<sub>ICM</sub> were any higher than 8V, the internal node would run into the output high limit, and the output would clip.

For  $V_{ICM}$  = -8V, with -12V output, the minimum positive internal node swing is  $-6V$  below  $V_{ICM}$ . Referenced to ground, this internal node can hit a minimum of –6V  $+$  (-8V) = -14V, which is roughly the output low limit of LTC6373 with  $\pm$ 15V supplies. If V<sub>ICM</sub> were any lower than −8V, this internal node would run into the output low limit, and the output would clip.

#### **Output Common Mode and VOCM Pin**

The output common mode voltage is defined as the average of the two outputs:

 $V_{\text{OUTCM}} = (V_{+OUT} + V_{-OUT})/2 = V_{\text{OCM}}$ 

As the equation shows, the output common mode voltage is independent of the input common mode voltage, and is instead determined by the voltage on the  $V_{\Omega CM}$  pin, by means of an internal common mode feedback loop. If the  $V_{\text{OCM}}$  pin is left floating, an internal resistor divider creates a default voltage approximately halfway between V $^{\rm +}$ <sub>OUT</sub> and V<sup>-</sup>. The V<sub>OCM</sub> pin can be overdriven to another voltage if desired for greater accuracy or flexibility. For example, when driving an ADC, if the ADC makes a reference available for setting the common mode voltage, it can be directly tied to the  $V_{\Omega CM}$  pin, as long as the ADC is capable of driving the  $2.3M\Omega$  input resistance presented by the  $V_{\text{OCM}}$  pin. The [Electrical Characteristics](#page-2-0) table specifies the valid range that can be applied to the  $V_{\text{OCM}}$  pin (VOUTCMR).

#### **Input Pin Protection**

To prevent damage, the LTC6373 has a comprehensive protection scheme, especially on the input pins, as illustrated in the Simplified Block Diagram of [Figure 1](#page-16-0). The input current applied to the LTC6373's input pins should be kept under ±10mA. To achieve additional input protection, external series resistors and/or low leakage clamp diodes should be used.

#### **Reducing Board-Related Leakage Effects**

Leakage currents can have a significant impact on system accuracy, particularly in high temperature and high voltage applications. Quality insulation materials should be used, and insulating surfaces should be cleaned to remove fluxes and other residues. For humid environments, surface coating may be necessary to provide a moisture barrier.

Leakage into the input pins reacts with the source resistance, creating an error directly at the input. As shown in [Figure 4](#page-20-0), this leakage can be minimized by enclosing the input connections with guard rings operated at a potential very close to that of the input pins. For the lowest leakage, amplifiers can be used to drive the guard rings. These buffers must have very low input bias current since that current will now be a leakage current.



<span id="page-20-0"></span>**Figure 4. Guard Rings Can Be Used to Minimize Leakage into the Input Pins**

#### **Input Bias Current Return Path**

The low input bias current (25pA max) and high input impedance (5000GΩ) of the LTC6373 allow the use of high impedance sources without introducing additional offset voltage errors, even when the full common mode range is required. However, a DC path must be provided for the input bias currents of both inputs when a purely differential signal is being amplified. Without this path, the inputs will float to either rail and exceed the input voltage range of the LTC6373, resulting in a saturated input amplifier. [Figure 5](#page-21-0) shows three examples of an input bias current path. The first example is of a purely differential signal source with a 10k $\Omega$  input current path to ground. Since the impedance of the signal source is low, only one resistor is needed. Two matching resistors are needed for higher impedance signal sources as shown in the second example. Balancing the input impedance improves both DC and AC common mode rejection as well as DC offset. The need for input resistors is eliminated if a center tap is present as shown in the third example.



**Figure 5. Providing an Input Common Mode Current Path**

#### **RF Interference**

In many industrial and data acquisition applications, the LTC6373 will be used to process small signals accurately in the presence of large common mode voltages or high levels of noise. Typically, the sources of these very small signals (on the order of microvolts or millivolts) are sensors that can be a significant distance from the signal conditioning circuit. Although these sensors may be connected to signal conditioning circuitry using shielded or unshielded twisted-pair cabling, the cabling may act as an antenna, conveying very high frequency interference directly into the input stage of the LTC6373.

The amplitude and frequency of the interference can have an adverse effect on an instrumentation amplifier's input stage by causing an unwanted DC shift in the amplifier's input offset voltage. This well known effect is called RFI rectification and is produced when out-of-band interference is coupled (inductively, capacitively, or via radiation) and rectified by the instrumentation amplifier's input transistors. These transistors act as high frequency signal detectors, in the same way diodes were used as RF envelope detectors in early radio designs. Regardless of the type of interference or the method by which it is coupled into the circuit, an out-of-band error signal appears in series with the instrumentation amplifier's inputs.

To help minimize this effect, high frequency signals can be filtered with a low pass RC network placed at the input of the LTC6373, as illustrated in [Figure 6](#page-21-1). The

<span id="page-21-0"></span>

<span id="page-21-1"></span>**Figure 6. Adding a Simple External RC Filter at the Inputs of the LTC6373 Is Effective in Suppressing RF Interference.**

filter limits the input signal bandwidth according to the following formulas:

FilterFreq<sub>DIFF</sub> =  $1/[2 \cdot \pi \cdot R_S \cdot (C_C + 2C_D)]$ 

FilterFreq<sub>CM</sub> =  $1/[2 \cdot \pi \cdot R_S \cdot C_C]$ 

Setting the filter frequencies requires knowledge of the frequency (or frequencies) of the RF interference. Once the interference frequency is known, the common mode filter frequency can be set (low enough to filter out the interference frequency) followed by the differential mode filter frequency. To avoid any possibility of inadvertently affecting the differential signal of interest, set the common mode filter frequency an order of magnitude (or more) higher than the differential mode filter frequency. Set the common mode filter frequency such that it does not

degrade the LTC6373's inherent AC CMRR. To avoid any possibility of common mode to differential mode signal conversion, match the common mode filter frequencies (on positive and negative inputs of LTC6373) to 1% or better. Then the differential mode filter frequency can be set for the bandwidth of the signal to be processed in the application. Setting the differential mode filter frequency close to the sensor's bandwidth also minimizes any noise pickup along the leads. If the sensor is an RTD or a resistive strain gauge in close proximity to the LTC6373, then the series resistors  $R<sub>S</sub>$  can be omitted. As an example, if the bandwidth of the signal of interest is 100kHz whereas the interference frequency is 10MHz and above, an appropriate choice for differential mode filter (FilterFreq<sub>DIFF</sub>) and common mode filter (FilterFreq $_{\text{CM}}$ ) frequencies could be 200kHz/4MHz. Assuming R<sub>S</sub> is chosen to be 1k $\Omega$ , using the formula provided earlier in this section results in  $C_C$  = 39pF and  $C_D$  = 390pF.

#### **Error Budget Analysis**

[Figure 7](#page-22-0) shows the LTC6373 in a typical application to buffer and amplify the differential output of a bridge transducer. The LTC6373 is programmed to a gain of 8V/V

#### <span id="page-22-1"></span>**Table 2. Error Budget Analysis**

in this example and amplifies a differential, full-scale (FS) voltage of  $100 \text{mV} = 0.1 \text{V}$  at transducer's output (or LTC6373's input). [Table 2](#page-22-1) shows the error budget in this application, listing various error sources in parts per million (ppm) normalized to full-scale voltage (0.1V) and across the temperature range of 25°C to 85°C. The LTC6373 achieves superior performance compared to all other monolithic programmable-gain instrumentation amplifiers (PGIA) in the market, enabling more accurate measurements.



<span id="page-22-0"></span>**Figure 7. Precision Bridge Amplifier**



#### **Dynamic Power Consumption Calculation**

As shown in the Simplified Block Diagram of [Figure 1,](#page-16-0) the LTC6373 has three internal chains of gain setting resistors. To achieve a low wideband noise for the LTC6373, a relatively small value, 4kΩ, has been chosen for the total resistance of each chain. The voltages across the three chains are:

- 1)  $V_{\text{OUIT}}$ A1 to  $-$ OUT
- 2)  $V_{\text{OIII}}$ A2 to +OUT
- 3)  $V_{OIII}$ A1 to  $V_{OIII}$ A2

Each of these voltages is imposed across what is effectively one 4k $\Omega$  resistor, establishing currents in them. These three currents are independent of each other and the part's quiescent supply current  $(I<sub>S</sub>)$ , and all of them are drawn from the supplies.

For example, assume LTC6373 is being used with  $±15V$ supplies (i.e.,  $V^+ = V^+_{\text{OUT}} = 15V, V^- = -15V$ ),  $V_{\text{OCM}} = 0V$ ,  $G = 2$ , and has input voltages of  $+IN = 3V$  and  $-IN = -3V$ (i.e.,  $V_{ICM} = 0V$ ,  $V_{INDIF} = 6V$ ). The resulting output voltage is  $V_{\text{OUTDIFF}} = 2 \cdot V_{\text{INDIFF}} = 12V$ . Since  $V_{\text{OUTCM}} = V_{\text{OCM}} = 0V$ , this implies that the value of LTC6373's output voltages  $are +OUT = 6V, -OUT = -6V.$ 

Since the gain is applied in the A1 and A2 amplifiers, the output voltages of these internal amplifiers are  $V_{\text{OUT}}$ A1 = +6V and  $V_{\text{OUT}}$ A2 = -6V, respectively.

Thus, the voltages and currents in each  $4k\Omega$  resistor chain are:

$$
I1 = [(V0UTA1) – (-0UT)]/4kΩ
$$
  
\n= [6V – (-6V)]/4kΩ  
\n= 3mA  
\n
$$
I2 = [(+0UT) – (V0UTA2)]/4kΩ
$$
  
\n= [6V – (-6V)]/4kΩ  
\n= 3mA  
\n
$$
I3 = [(V0UTA1) – (V0UTA2)]/4kΩ
$$
  
\n= [6V – (-6V)]/4kΩ  
\n= 3mA

Therefore, the total supply current is:

 $I_{\text{TOTAI}} = I_S + I_1 + I_2 + I_3 = 4.4 \text{mA} + 3 \cdot 3 \text{mA} = 13.4 \text{mA}$ 

In case the output pins (+OUT, −OUT) of the LTC6373 connect to resistive loads, the currents provided by the LTC6373 to these loads should also be added to the calculations above.

#### **Board Layout and Bypass Capacitors**

It is recommended that high quality 0.1μF ceramic bypass capacitors be placed directly between the V+ pin and the  $V^-$  pin (exposed pad), between  $V^+$  and ground plane, and between  $V^-$  and ground plane with minimal routing. In applications where  $\mathsf{V^+}_{\mathsf{OUT}}$  pin is not directly connected to V+, it is recommended that additional high quality 0.1μF ceramic capacitors be used to bypass  $V^+$ <sub>OUT</sub> to ground and V $_{\rm{OUT}}$  to V<sup>–</sup>, again with minimal routing. Small geometry (e.g., 0603) surface mount ceramic capacitors have a much higher self-resonant frequency than leaded capacitors, and perform best with the LTC6373.

Always keep in mind the differential nature of the LTC6373. At the inputs, keep any (intended or parasitic) resistance and capacitance as balanced and symmetric as possible to preserve AC CMRR performance of the amplifier. Apply the same practice at the output, because it is equally critical that the load impedances seen by both outputs (intended or parasitic) be as balanced and symmetric as possible. This will help preserve the balanced operation of the LTC6373 that minimizes the generation of even-order harmonics and maximizes the rejection of common mode noise and signals.

To minimize thermocouple induced errors, further attention must be given to board layout and component selection. It is good practice to minimize the number of junctions in the LTC6373's input signal paths and avoid connectors, sockets, switches, and relays whenever possible. If such components are required, they should be selected for low thermal EMF characteristics. Furthermore, the number, type, and layout of junctions should be matched for both inputs with respect to thermal gradients on the circuit board. Doing so may involve deliberately introducing dummy junctions to offset unavoidable junctions.

The  $V_{\text{OCM}}$  pin should be bypassed to the ground plane with a high quality 0.1μF ceramic capacitor. This will prevent common mode signals and noise on this pin from being inadvertently converted to differential signals and noise by

impedance mismatches internally to the IC. Additionally, the CAP pin should be bypassed to the ground plane with a high quality 180pF ceramic capacitor to ensure proper operation of LTC6373 across its different gain settings.

To prevent coupling noise onto LTC6373, shield fast switching digital signals where they are in proximity of analog signals on the board.

#### **Driving High Precision ADCs**

The LTC6373 makes an excellent PGIA for use in data acquisition systems. Attributes such as fully differential outputs, good DC precision, low noise, low distortion, and high bandwidth enable LTC6373 to drive ADCs directly in many signal conditioning applications. The recommended list of precision SAR ADCs for use with the LTC6373 is shown in [Table 3.](#page-24-0) The circuit in Figure 8 shows an example of the LTC6373 driving a precision ADC such as the AD4020 (a 20-bit, 1.8Msps, SAR ADC) or AD7134 (a 24-bit, 1.5Msps, Continuous-Time, ∑-∆ ADC). The LTC6373 is DC-coupled on the input and the output,

<span id="page-24-0"></span>

which eliminates the need for a transformer to drive the ADC. The LTC6373 gain is programmed to its desired setting using A2/A1/A0 pins, as previously described in the Gain Selection section of this data sheet. In the example of [Figure 8,](#page-25-0) the LTC6373 is being used in a differential input to differential output configuration with dual supplies of  $\pm$ 15V. It can also be used in a single-ended input to differential output configuration.

The  $V_{OCM}$  pin is biased to  $V_{REF}/2$  (which is provided directly by the ADC in some products). This achieves level shifting of the outputs of the LTC6373 to match the desired input common mode of the ADC. In Figure 8, each of the LTC6373 outputs swings between OV and  $V_{\text{RFF}}$ (opposite in phase), thus providing  $2V_{RFF}$  peak-to-peak differential signal to the ADC inputs. In some cases, an RC network between the LTC6373 outputs and the ADC inputs is required providing a single-pole, low-pass filter to help reduce nonlinear charge kickback due to ADC input switching as well as limiting the broadband noise.





**Figure 8. LTC6373 Driving Precision ADC**

As a more specific example, [Figure 9](#page-25-1) and [Figure 10](#page-25-2) show typical Signal-to-Noise Ratio (SNR) and Total Harmonic Distortion (THD) of the LTC6373 driving the AD4020 SAR ADC (with high-Z mode enabled) at a near full-scale signal

<span id="page-25-0"></span>for various ADC throughputs. The recommended RC filter values used in [Figure 8](#page-25-0) for optimum performance at each throughput are listed in [Table 4,](#page-25-3) as well as the selected reference voltage  $(V_{RFF})$ .

<span id="page-25-3"></span>





<span id="page-25-1"></span>

<span id="page-25-2"></span>

**Figure 9. SNR for LTC6373 Driving AD4020 Figure 10. THD for LTC6373 Driving AD4020**

[Table 5](#page-26-0) lists the typical SNR and THD achieved when the ADC used in Figure 8 is AD7134 ∑-∆ ADC being driven directly (with no RC filter in between) by the LTC6373 at a near full-scale signal.

In some applications, it might be beneficial to use a separate amplifier/ADC driver between the LTC6373 and the precision ADC to ease the settling requirements on the LTC6373 and improve the linearity and THD performance of the signal chain. An implementation of such signal chain can be achieved by using the ADAQ4003, a precision data acquisition µModule which integrates multiple signal conditioning and processing blocks inside a single package. These blocks include a fully differential ADC driver, a stable reference buffer, an 18-bit, 2Msps,

SAR ADC, as well as critical passive components necessary for optimum performance. This µModule achieves 4X footprint reduction by itself (compared to discrete solution) without sacrificing any performance.

The ADAQ4003 offers pin-selectable gain or attenuation options, giving the user the flexibility to match to their input signal range. This is showcased in [Figures 11-19](#page-27-0)  as LTC6373 is directly driving the ADAQ4003 at its 3 different gain options, in each case providing the signal amplitude necessary to utilize the maximum  $2V_{BFF}$  peakto-peak differential signal range of the ADC inside the ADAQ4003 µModule.

<span id="page-26-0"></span>



#### **Table 6. Details for LTC6373 Driving ADAQ4003 at 3 Different Gain Options and Signal Amplitudes**





**Figure 11. LTC6373 Driving ADAQ4003 (Gain = 0.454)**



**Figure 12. SNR for LTC6373 Driving ADAQ4003 (Gain = 0.454) Figure 13. THD for LTC6373 Driving ADAQ4003 (Gain = 0.454)**

<span id="page-27-0"></span>



**Figure 14. LTC6373 Driving ADAQ4003 (Gain = 0.9)**



**Figure 15. SNR for LTC6373 Driving ADAQ4003 (Gain = 0.9) Figure 16. THD for LTC6373 Driving ADAQ4003 (Gain = 0.9)**



Rev. 0



**Figure 17. LTC6373 Driving ADAQ4003 (Gain = 1.9)**



**Figure 18. SNR for LTC6373 Driving ADAQ4003 (Gain = 1.9) Figure 19. THD for LTC6373 Driving ADAQ4003 (Gain = 1.9)**



As another data acquisition system example, the circuit of Figure 20 shows the LTC6373 driving the AD7768-1 (a 24-bit, 256ksps, ∑-∆ ADC) through the ADA4945-1 (a high speed, fully differential ADC driver). The ADC driver in this circuit has been configured with a closed-loop gain of 1.3V/V (by using matched discrete resistors) and once

again the LTC6373 in conjunction with the ADA4945-1 provide the maximum  $2V_{\text{RFF}}$  peak-to-peak differential signal range needed at the AD7768-1 inputs. More details about this circuit can be found in [Table 7](#page-30-0) and the typical SNR and THD achieved by this signal chain are illustrated in [Figure 21](#page-31-0) and [Figure 22.](#page-31-1)

#### <span id="page-30-0"></span>**Table 7. Details for LTC6373 Driving AD7768-1 Through ADA4945-1**









<span id="page-31-0"></span>**Figure 21. SNR for LTC6373 + ADA4945-1 + AD7768-1 Signal Chain** 



<span id="page-31-1"></span>**ADA4945-1 + AD7768-1 Signal Chain** 

### PACKAGE DESCRIPTION



**DFM Package** 12-Lead Plastic Side Solderable DFN (4mm  $\times$  4mm) (Reference LTC DWG # 05-08-1791 Rev Ø)

NOTE:

1. PACKAGE OUTLINE DOES NOT CONFORM TO JEDEC MO-229 2. DRAWING NOT TO SCALE

3. ALL DIMENSIONS ARE IN MILLIMETERS

4. DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.15mm ON ANY SIDE 5. EXPOSED PAD SHALL BE SOLDER PLATED

6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE



